

| Examiner Art Unit Page 1 of 1 | Application/Con. 6. | Applicant(s)/Patent Under Reexamination IWAMOTO ET AL. | | |
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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|----|---|-----------------|---------------------|----------------|
| | Α | US-6,271,606 | 08-2001 | Hazelton, Andrew J. | 250/491.1 |
| | В | US-5,858,587 | 01-1999 | Yamane et al. | 355/53 |
| | C | US-2001/0052967 | 03-2001 | Ogura et al. | 355/53 |
| | D | US-6,252,234 | 06-2001 | Hazelton et al. | 250/442.11 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | н | US- | | | |
| | _ | US- | | | |
| | J | US- | | | |
| | Κ | US- | | | |
| | L. | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|----|--|-----------------|---------|------|----------------|
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| | R | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
YYY format are publication dates. Classifications may be US or foreign.

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Notice of References Cited

Part of Paper No. 6